

STW63N65DM2

N-channel 650 V, 0.042 Ω typ., 60 A MDmesh™ DM2 Power MOSFET in a TO-247 package

Datasheet - production data

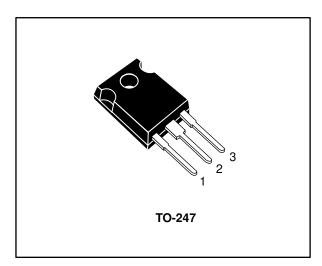
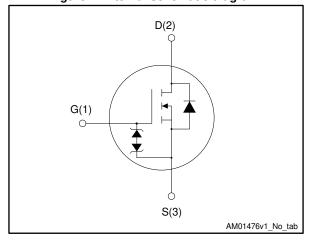


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	P _{TOT}
STW63N65DM2	650 V	0.05 Ω	60 A	446 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

Switching applications

Description

This high-voltage N-channel Power MOSFET is part of the MDmesh $^{\mathsf{TM}}$ DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{\mathsf{DS}(\mathsf{on})}$, rendering it suitable for the most demanding high-efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STW63N65DM2	63N65DM2	TO-247	Tube

Contents STW63N65DM2

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STW63N65DM2 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit	
V _{GS}	Gate-source voltage	±25	V	
I-	Drain current (continuous) at T _{case} = 25 °C		^	
l _D	Drain current (continuous) at T _{case} = 100 °C	38	Α	
I _{DM} ⁽¹⁾	Drain current (pulsed) 240			
P _{TOT}	Total dissipation at T _{case} = 25 °C 446			
dv/dt ⁽²⁾	Peak diode recovery voltage slope	50	V/ns	
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness		V/IIS	
T _{stg}	Storage temperature range			
Tj	Operating junction temperature range	-55 to 150	°C	

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.28	0000
R _{thj-amb}	Thermal resistance junction-ambient 50		°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
lar	Avalanche current, repetitive or non-repetitive	8	Α
E _{AS} ⁽¹⁾	Single pulse avalanche energy	1100	mJ

Notes:

 $^{(1)}Starting~T_{j}=25~^{\circ}C,~I_{D}=I_{AR},~V_{DD}=50~V.$

 $[\]ensuremath{^{(1)}}\mbox{Pulse}$ width is limited by safe operating area.

 $^{^{(2)}}I_{SD} \leq 60$ A, di/dt=800 A/ μ s, V $_{DS}$ peak < V $_{(BR)DSS}$, V $_{DD}$ = 80% V $_{(BR)DSS}$

 $^{^{(3)}}V_{DS} \le 520 \text{ V}$

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			٧
	Zoro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			10	
IDSS	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V},$ $T_{case} = 125 \text{ °C}^{(1)}$			100	μΑ
Igss	Gate-body leakage current	V _{DS} = 0 V, V _{GS} = ±25 V			±5	μΑ
$V_{\text{GS(th)}}$	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 30 A		0.042	0.05	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	5500	1	
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$	-	210	1	рF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	3	ı	ρ.
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0$ to 520 V, $V_{GS} = 0$ V	1	456	ı	pF
Rg	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	-	3.3	-	Ω
Qg	Total gate charge	$V_{DD} = 520 \text{ V}, I_{D} = 60 \text{ A},$	-	120	1	
Q _{gs}	Gate-source charge	V _{GS} = 0 to 10 V (see <i>Figure 15: "Test circuit for</i>	-	27	1	nC
Q_{gd}	Gate-drain charge	gate charge behavior")	-	58	-	

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 325 \text{ V}, I_D = 30 \text{ A}$	1	33	1	
tr	Rise time	R _G = 4.7 Ω , V _{GS} = 10 V (see Figure 14: "Test circuit for	1	13.5	ı	
$t_{\text{d(off)}}$	Turn-off delay time	resistive load switching times"	1	114	ı	ns
t _f	Fall time	and Figure 19: "Switching time waveform")	-	11.5	,	



 $^{^{(1)}\}mbox{Defined}$ by design, not subject to production test.

 $^{^{(1)}}$ C_{oss eq.} is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}.

Table 8: Source-drain diode

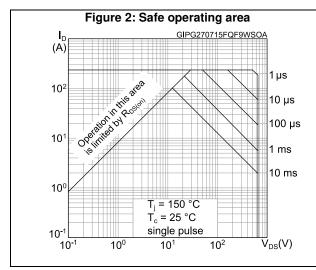
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		60	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		240	Α
V _{SD} ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 60 A	1		1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 60 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	1	154		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for	-	0.94		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	ı	12.2		Α
t _{rr}	Reverse recovery time	$I_{SD} = 60 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	1	288		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 ^{\circ}\text{C}$ (see Figure 16: "Test circuit for	-	3.65		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	25.4		Α

Notes:

 $^{^{(1)}}$ Pulse width is limited by safe operating area.

 $^{^{(2)}\}text{Pulse}$ test: pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

2.1 Electrical characteristics (curves)



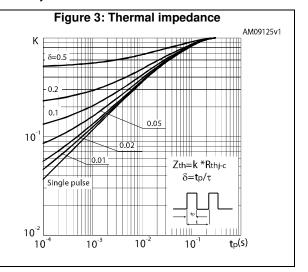


Figure 4: Output characteristics

ID GIPG270715FQF9WOCH

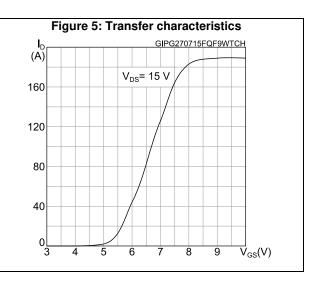
VGS = 9, 10 V

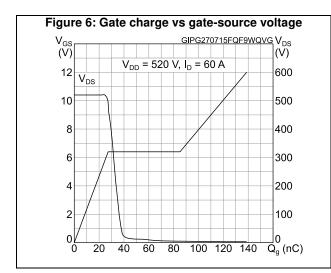
VGS = 7 V

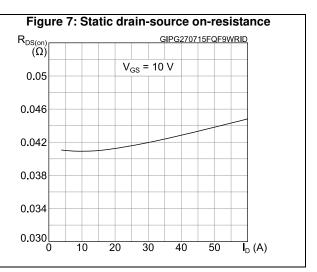
120

VGS = 6 V

VGS = 5 V







STW63N65DM2 Electrical characteristics

Figure 8: Capacitance variations C (pF) GIPG270715FQF9WCVR 10⁴ C_{ISS} 10^{3} Coss 10² f = 1 MHz 10¹ C_{RSS} 10⁰ $\overline{V}_{DS}(V)$ 10⁻¹ 10⁰ 10¹ 10²

Figure 9: Normalized gate threshold voltage vs temperature V_{GS(th)} (norm.) GIPG270715FQF9WVTH $I_D = 250 \, \mu A$ 1.1 1.0 0.9 0.8 0.7 0.6 -75 25 75 T_i (°C) -25 125

Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG270715FQF9WRON
(norm.)

2.2

1.8

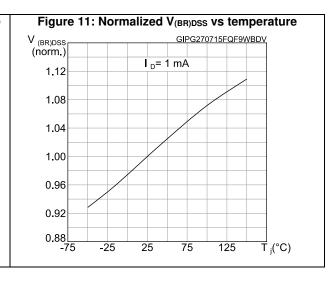
1.4

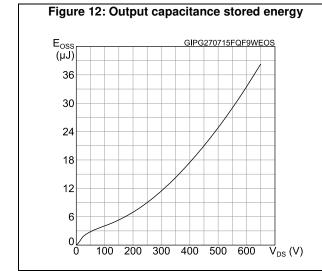
1.0

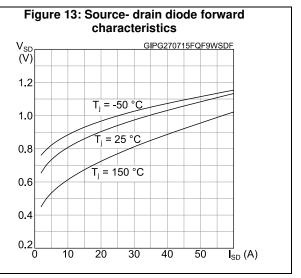
0.6

0.2

-75
-25
25
75
125
T_j (°C)



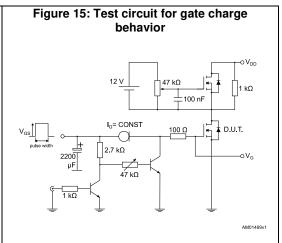


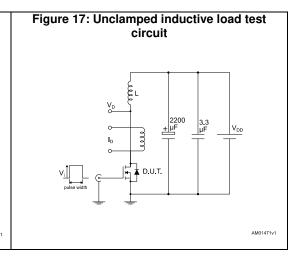


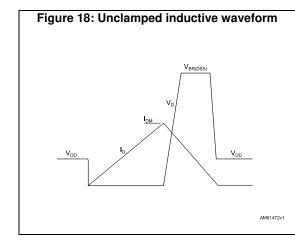
Test circuits STW63N65DM2

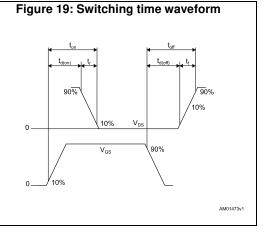
3 Test circuits

Figure 14: Test circuit for resistive load switching times









STW63N65DM2 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

HEAT-SINK PLANE øΡ S øR Ľ2 *b1 b2* BACK VIEW 0075325_8

Figure 20: TO-247 package outline

Table 9: TO-247 package mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
Е	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STW63N65DM2 Revision history

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
05-May-2017	1	Initial release

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